

**Search Notes**

Application/Control No.

10/665,982

Examiner

Eric B. Chen

Applicant(s)/Patent under  
Reexamination

ERK ET AL.

Art Unit

1765

**SEARCHED**

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|   | DATE      | EXMR |
|---|-----------|------|
| Inventor search (PALM) (UPDATED)                                  | 3/16/2006 | EC   |
| EAST (all databases) (UPDATED) -<br>see search history printout   | 3/16/2006 | EC   |
| 216/89-91,99; 438/689-693,745,753<br>(text search only) (UPDATED) | 3/16/2006 | EC   |
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